



FQB11N40C/FQI11N40C

400V N-Channel MOSFET

General Description

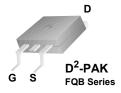
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction, electronic lamp ballasts based on half bridge topology.

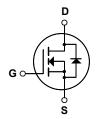
Features

- 10.5 A, 400V, $R_{DS(on)} = 0.5 \Omega @V_{GS} = 10 V$
- Low gate charge (typical 28 nC)
- Low Crss (typical 85pF)
- Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant









Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQB11N40C / FQI11N40C	Units
V _{DSS}	Drain-Source Voltage		400	V
I _D	Drain Current - Continuous (T _C = 25°C)		10.5	Α
	- Continuous (T _C = 100°C)		6.6	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	42	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	360	mJ
I _{AR}	Avalanche Current	(Note 1)	11	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	13.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P_D	Power Dissipation (T _C = 25°C)		135	W
	- Derate above 25°C		1.07	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	-	0.93	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *	-	40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	-	62.5	°C/W

* When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	400			V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C	-	0.54		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 400 V, V _{GS} = 0 V	-		1	μΑ
		V _{DS} = 320 V, T _C = 125°C	-		10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V	-		100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Cha	racteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 5.25 A		0.5	0.53	Ω
g _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 5.25 A (Note 4)		7.1		S
C _{iss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		250	1090 325	pF pF
C _{rss}	•			85	110	pF
	ing Characteristics	I				
t _{d(on)}	Turn-On Delay Time	V _{DD} = 200 V, I _D = 10.5 A,		14	40	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$	-	89	190	ns
t _{d(off)}	Turn-Off Delay Time	(Note 4, 5)		81	170	ns
t _f	Turn-Off Fall Time	, , ,		81	170	ns
Q _g	Total Gate Charge	$V_{DS} = 320 \text{ V}, I_D = 10.5 \text{ A},$		28	35	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V (Note 4, 5)		4 15		nC nC
Q _{gd}	Gate-Drain Charge	(14016 4, 3)	-	15		ПС
Drain-S	ource Diode Characteristics a	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current		-		10.5	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	sed Drain-Source Diode Forward Current			42	Α
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 10.5 \text{ A}$	-		1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = 10.5 \text{ A},$		290		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$ (Note 4)		2.4		μC

- Notes: 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 5.7 mH, I_{AS} = 10.5A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C 3. $I_{SD} \leq$ 10.5A, di/dt \leq 200A/µs, $V_{DD} \leq$ BVDss, Starting T_{J} = 25°C 4. Pulse Test : Pulse width \leq 300µs, Duty cycle \leq 2% 5. Essentially independent of operating temperature

Typical Characteristics

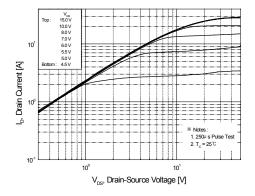


Figure 1. On-Region Characteristics

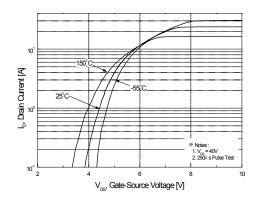


Figure 2. Transfer Characteristics

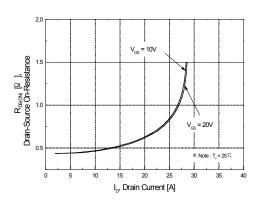


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

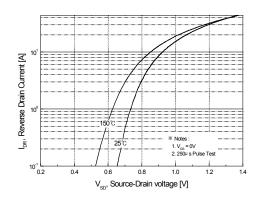


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

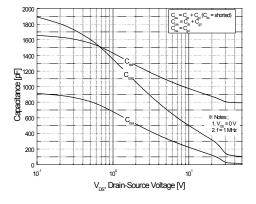


Figure 5. Capacitance Characteristics

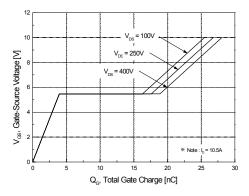
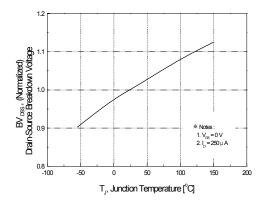


Figure 6. Gate Charge Characteristics

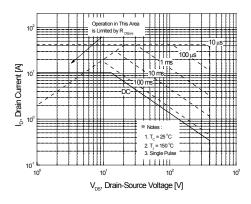
Typical Characteristics (Continued)



30 25 (987) 1.5

Figure 7. Breakdown Voltage Variation vs Temperature

Figure 8. On-Resistance Variation vs Temperature



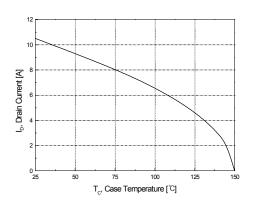


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs Case Temperature

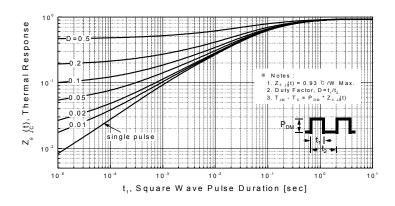
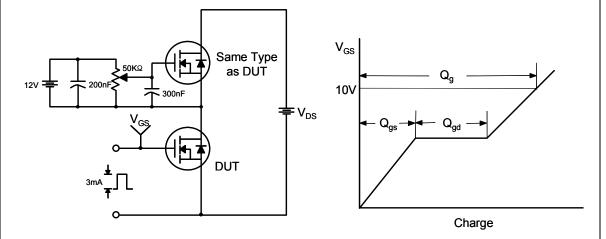


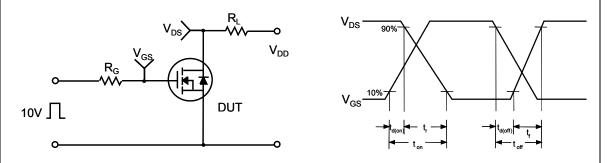
Figure 11. Transient Thermal Response Curve

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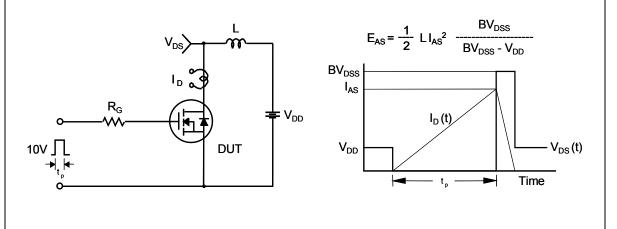
Gate Charge Test Circuit & Waveform



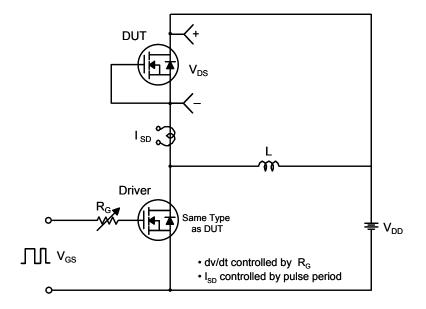
Resistive Switching Test Circuit & Waveforms

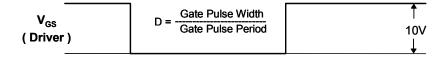


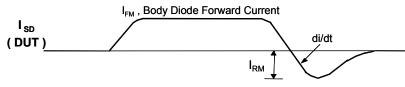
Unclamped Inductive Switching Test Circuit & Waveforms



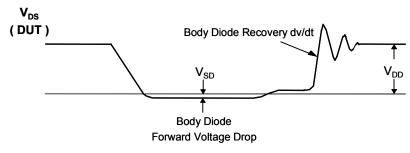
Peak Diode Recovery dv/dt Test Circuit & Waveforms

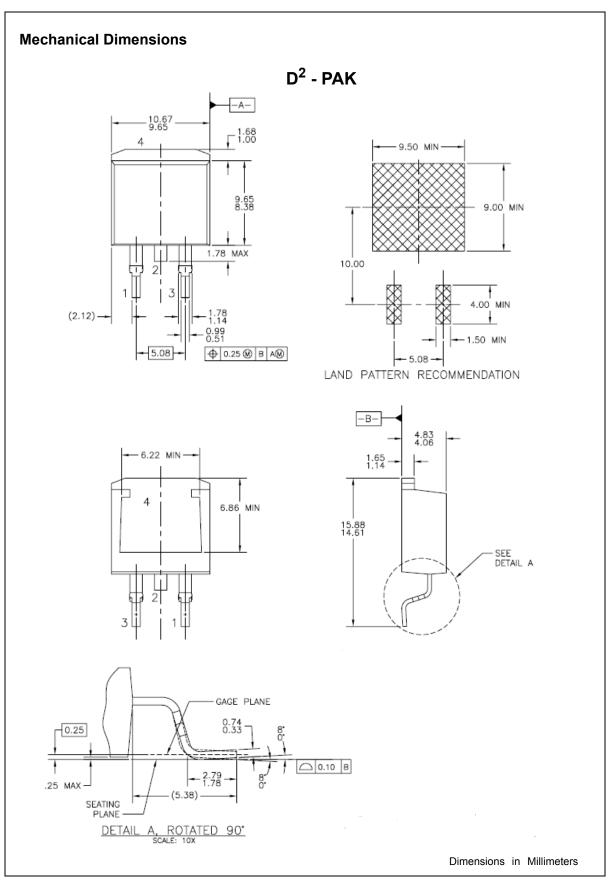






Body Diode Reverse Current





Mechanical Dimensions I² - PAK 10.29 4.83 4.06 9.65 В 8.33 1.40 1.00 1.40 6.22 1.14 7.88 9.65 6.86 8.64 \oplus 3 B 3.96 2.80 (2.13) 14.73 12.70 2.79 2.03 1.78 1.14 B 0.64 0.33 ∑ 0.90 0.64 2.54 5.08 ⊕ 0.254 AM B Dimensions in Millimeters





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